Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,257	YIM ET AL.	
Examiner	Art Unit	
Wilson Tsui	2178	

	SEAR	CHED	
Class	Subclass	Date	Examiner
715	523	12/21/2006	WT
715	515	12/21/2006	WT
715	523	12/21/2006	WT
715	788	12/21/2006	WT
715	526	12/21/2006	WT

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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East Search USPGPUB, USPAT See Notes	12/21/2006	wr		
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